Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination DENGLER, STEFAN	
10/577,048		
Examiner	Art Unit	
CHING CHANG	3748	

SEARCHED					
	JEAN				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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